

HP 3070

- Flash memory programming capability
- Comprehensive in-circuit and functional test
- 5280 node capacity

With the HP 3070 board test system, you can eliminate additional flash memory programming steps and avoid possible chip damage induced by excessive handling by programming in-line. Here is a sample of approximate speeds across varying Flash Memory sizes.

Flash Memory Size	Program Time in Seconds
1 Mbit	4.7
2 Mbit	8.88
4 Mbit	17.2
8 Mbit	24

The HP 3070 board test family is the most comprehensive, compatible board test system on the market, ranging from the small footprint, unpowered HP 3272 to the full-spectrum combinational HP 3075 with a 5280 node capacity. Our industry-leading technologies for boundary scan-HP InterconnectPlus, vectorless testing-HP TestJet, and reversed polarized capacitor testing-HP Polarity Check, are available across the family. Thanks to the shared architecture, test and fixtures created on one HP system are transportable to any other HP 3070 family member.



INTEL FLASH MEMORY SUPPORTED:

28F010, 28F001BX, 28F020, 28F002BC, 28F002BL, 28F002BV, 28F002BX, 28F200BL, 28F200BV, 28F200BX, 28F200CV, 28F004BE, 28F004BL, 28F004BV, 28F004BX, 28F004SC, 28F400BL, 28F400BV, 28F400BX, 28F400CE, 28F400CV, 28F008BE, 28F008BV, 28F008SA, 28F008SC, 28F800BV, 28F800CE, 28F800CV, 28F016SA, 28F016SC, 28F016SV, 28F016XD, 28F016XS, 28F032SA

AVAILABILITY:

Now

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